

### 承 認 書 SPECIFICATION FOR APPROVAL

客戶名稱 CUSTOMER	:	
客户料號 CUSTOMER'S P/N	:	
料號 PART NUMBER	:	WAN3216F245H08
規格 DESCRIPTION	:	Chip Antenna 3216 L Ant 2.45G Type H08
版本 VERSION	:	V1.6
日期 ISSUF DATE	:	2022/01/05

客戶承認 CUSTOMER APPROVED

工 程 部 R&D CENTER				
承 認 APPROVAL	確 認 CHECKED	製 作 DRAWN		
Ray	Tennyson	Snow		





#### 萬誠科技股份有限公司

11261 台北市北投區立功街 151 號 1 樓

電話: (02) 2898-2220 傳真: (02) 2898-5055

#### OneWave Electronic Co., Ltd.

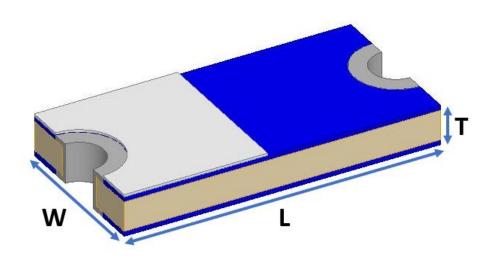
1F, No. 151, Li Gong Street, Beitou District,

Taipei City 11261, Taiwan TEL: +886 2 2898-2220 FAX: +886 2 2898-5055



# 3216 Chip antenna

### For Bluetooth / WLAN Applications



P/N: WAN3216F245H08

	Dimension (mm)
L	3.23 ± 0.20
W	1.66 ± 0.20
Т	0.45 ± 0.20



#### **Part Number Information**

WAN 3216 F 245 H 08
A B C D E F

Α	<b>Product Series</b>	Antenna
В	Dimension L x W	3.2 x 1.6mm (±0.2mm)
C	Material	High K material
D	Working Frequency	2.4 ~ 2.5GHz
E	Feeding mode	PIFA & Single Feeding
F	Antenna type	Type = 08

#### 1. Electrical Specification

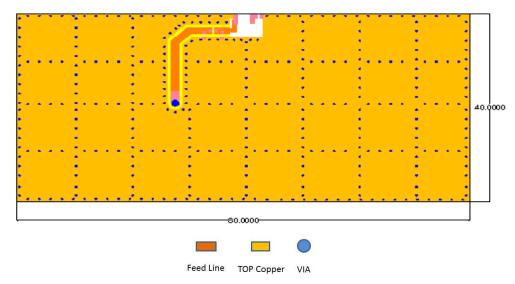
Specification			
Part Number	WAN3216F245H08		
Central Frequency	2450	MHz	
Bandwidth	120 (Min.)	MHz	
Return Loss	-6.5 (Max)	dB	
Peak Gain	1.75	dBi	
Impedance	50	Ohm	
Operating Temperature	-40~+110	$^{\circ}$ C	
Maximum Power	4	W	
Resistance to Soldering Heats	10 ( @ 260°C )	sec.	
Polarization	Linear		
Azimuth Beamwidth	Omni-directional		
Termination	Cu / Sn (Leadless)		

Remark: Bandwidth & Peak Gain was measured under evaluation board of next page

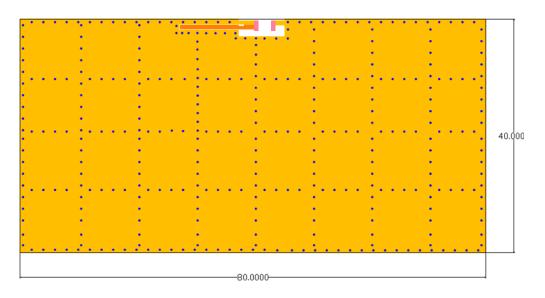


## 2. Recommended PCB Pattern

Recommended PCB Pattern 若未參照我司規格書上Layout建議做設計, Evaluation Board Dimension 進而造成後續生產上的天線特性與品質差異問題,



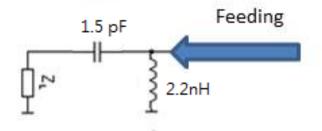
#### 2<sup>nd</sup> Evaluation Board Dimension



#### **Suggested Matching Circuit**

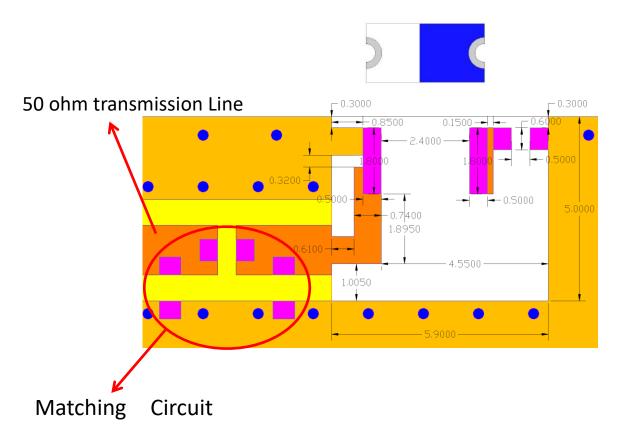
#### 重要資訊:

匹配元件建議使用精準度高的電感±0.1~0.3nH、電容±0.1pF

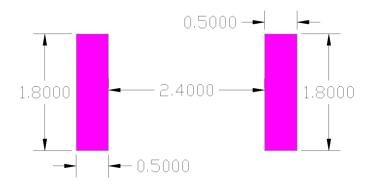




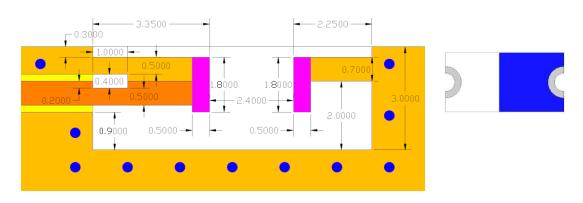
#### Layout Dimensions in Clearance area(Size=5.9\*5.0mm)



#### FootPrint (Unit:mm)

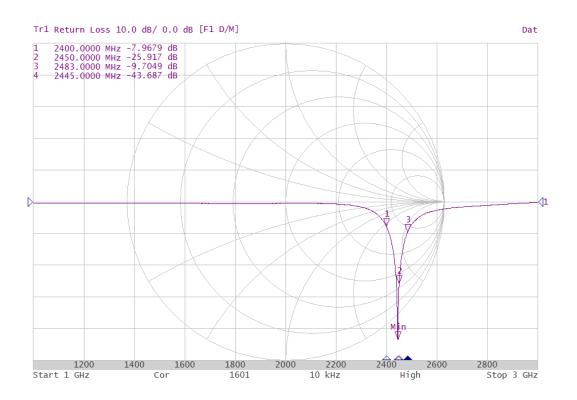


#### **◆ 2<sup>nd</sup> Layout Dimensions in Clearance area**(Size=8.0\*3.0mm)



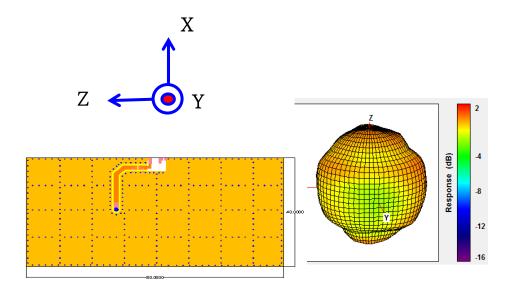


## 3. Measurement Results Return Loss



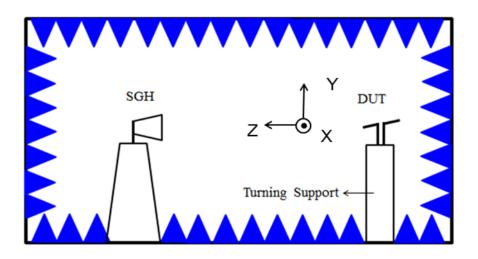


#### **Radiation Pattern**



	Efficiency	Peak Gain	Directivity
2400MHz	81.46%	1.67 dBi	2.56 dBi
2450MHz	84.75%	1.75 dBi	2.46 dBi
2500MHz	82.68%	1.70 dBi	2.52 dBi

#### **Chamber Coordinate System**





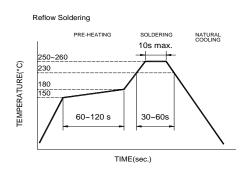
**4.Reliability and Test Condictions** 

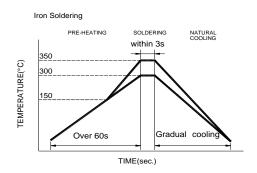
ITEM	REQUIREMENTS	TEST CONDITION		
Solderability	Wetting shall exceed 90% coverage     No visible mechanical damage	Pre-heating temperature:150°C/60sec.		
		Solder temperature:230±5°C Duration:4±1sec.		
	TEMP (°C)	Solder:Sn-Ag3.0-Cu0.5		
	4±1 sec.	Flux for lead free: rosin		
	230°C 4±1 Sec.			
	150°C			
	60sec			
Solder heat	No visible mechanical damage	Pre-heating temperature:150°C/60sec.		
Resistance	2. Central Freq. change :within ± 6%	Solder temperature:260±5°C		
	TEMP (℃)	Duration:10±0.5sec.		
	260°C 10±0.5 sec.	Solder:Sn-Ag3.0-Cu0.5 Flux for lead free: rosin		
	200 0	Flux for lead free. Tosiff		
	150℃			
	/ 60sec			
Component	1. No visible mechanical demage	The device chartel have "-"		
Component Adhesion	No visible mechanical damage	The device should be reflow soldered(230±5°C for 10sec.) to a tinned		
(Push test)		copper substrate A dynometer force		
		gauge should be applied the side of the		
		component. The device must with-ST-F		
		0.5 Kg without failure of the termination attached to component.		
Component	No visible mechanical damage	Insert 10cm wire into the remaining open		
Adhesion		eye bend ,the ends of even wire lengths		
(Pull test)		upward and wind together.		
(. a 1001)		Terminal shall not be remarkably		
		damaged.		
Thermal shock	No visible mechanical damage	+110°C=>30±3min		
	2. Central Freq. change :within ±6%	-40°C =>30±3min		
	Phase Temperature(℃) Time(min)	Test cycle:10 cycles		
	1 +110±5°C 30±3	The chip shall be stabilized at normal		
	- 14 Feb. 1	condition for 2~3 hours before		
	Room Within Temperature 3sec	measuring.		
	3 -40±2°C 30±3			
	0 0000			
	4   Room   Within   Temperature   3sec			
		Townsorthwest 1440 F°C		
Resistance to	No visible mechanical damage	Temperature: +110±5℃ Duration: 1000±12hrs		
High	2. Central Freq. change :within ±6%	The chip shall be stabilized at normal		
Temperature	3. No disconnection or short circuit.	condition for 2~3 hours before		
		measuring.		
Resistance to	No visible mechanical damage	Temperature:-40±5°C		
Low	2. Central Freq. change :within ±6%	Duration: 1000±12hrs		
Temperature		The chip shall be stabilized at normal		
	3. No disconnection or short circuit.	condition for 2~3 hours before		
		measuring.		
Humidity	No visible mechanical damage	Temperature: 40±2°C		
	2. Central Freq. change :within ±6%	Humidity: 90% to 95% RH Duration: 1000±12hrs The chip shall be stabilized at normal		
	3. No disconnection or short circuit.			
	S. 115 dissering stori of chart birduit.			
		condition for 2~3 hours before		
		measuring.		



#### 5. Soldering and Mounting

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.





Recommended temperature profiles for re-flow soldering in Figure 1.

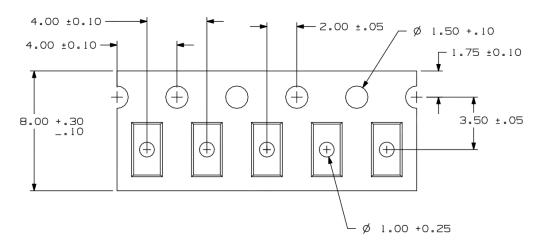
Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

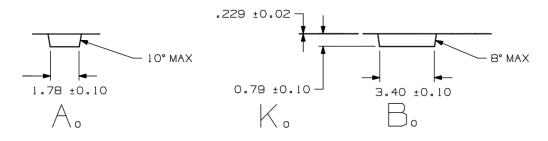
- Preheat circuit and products to 150°C
- Never contact the ceramic with the iron tip
- Use a 20 watt soldering iron with tip diameter of 1.0mm
- 280°C tip temperature (max)
- 1.0mm tip diameter (max)
- · Limit soldering time to 3 sec.



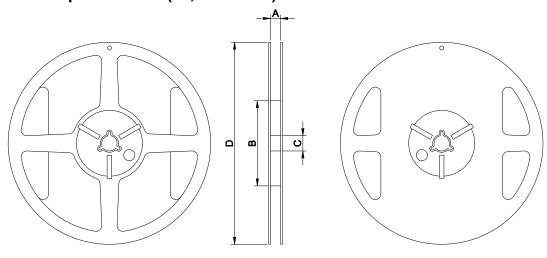
#### 6.Packaging Information

#### **Tape Specification:**





#### Reel Specification: (7", Ф180 mm)



7" x 8 mm

Tape Width(mm)	A(mm)	B(mm)	C(mm)	D(mm)	Chip/Reel(pcs)
8	9.0±0.5	60±2	13.5±0.5	178±2	3000



#### 7. Storage and Transportation Information

#### **Storage Conditions**

To maintain the solderability of terminal electrodes:

- 1. Temperature and humidity conditions: -10~ 40°C and 30~70% RH.
- 2. Recommended products should be used within 6 months from the time of delivery.
- 3. The packaging material should be kept where no chlorine or sulfur exists in the air.

#### **Transportation Conditions**

- 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.